

Search Notes

Application/Control No.

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Examiner

Hau V. Phan

Applicant(s)/Patent under
Reexamination

GAUKEL ET AL.

Art Unit

3618

SEARCHED

Class	Subclass	Date	Examiner
180	268 269 270	5/23/2006	HP
	271		
280	802	5/23/2006	HP
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701	46	5/23/2006	HP
	45		
	36		
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	107		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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